



Substitute Form PTO-1449	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 15826-202001	Application No. 10/750,103
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant John H. Bailey, et al.	
		Filing Date December 29, 2003	Group Art Unit 2863

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
FL	AA	6,424,922	7/23/2002	Bray	702	42	
FL	AB	6,477,473	11/5/2002	Bray	702	42	
FL	AC	6,523,418	2/25/2003	Bray	73	801	
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
FL	AQ	Basic Principles of Ultrasonic Testing, http://www.ndt-ed.org/EducationResources/CommunityCollege/Ultrasonics/Introduction , 10/8/2003, 3 pages
	AR	Wave Propagation, http://www.ndt-ed.org/EducationResources/CommunityCollege/Ultrasonics/Physics , 10/8/2003, 2 pages
	AS	Modes of Sound Wave Propagation, http://www.ndt-ed.org/EducationResources/CommunityCollege/Ultrasonics/Physics , 10/8/2003, 2 pages
	AT	Properties of Acoustic Plane Wave, http://www.ndt-ed.org/EducationResources/CommunityCollege/Ultrasonics/Introduction , 10/8/2003, 2 pages

Examiner Signature <i>John Se</i>	Date Considered <i>04/12/2005</i>
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 15826-202001	Application No. 10/750,103
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		Filing Date December 29, 2003	Group Art Unit <u>2863</u>

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
<u>FL</u>	AU	Wavelength and Defect Detection, http://www.ndt-ed.org/EducationResources/CommunityCollege/Ultrasonics/Physics , 10/8/2003, 2 pages
	AV	Sound Propagation in Elastic Materials, http://www.ndt-ed.org/EducationResources/CommunityCollege/Ultrasonics/Physics , 10/8/2003, 3 pages
	AW	Attenuation of Sound Waves, http://www.ndt-ed.org/EducationResources/CommunityCollege/Ultrasonics/Physics , 10/8/2003, 2 pages
	AX	Acoustic Impedance, http://www.ndt-ed.org/EducationResources/CommunityCollege/Ultrasonics/Physics , 10/8/2003, 2 pages
	AY	Reflection and Transmission Coefficients (Pressure), http://www.ndt-ed.org/EducationResources/CommunityCollege/Ultrasonics/Physics , 10/8/2003, 2 pages
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	AAA	Mode Conversion, http://www.ndt-ed.org/EducationResources/CommunityCollege/Ultrasonics/Physics , 10/8/2003, 3 pages
	ABB	Katronic Technologies Ltd. Manual, Sonometer 11, May 1997, 2 pages
	ACC	KATRONIC Clamp-on Ultrasonic Flowmeters and other Non-invasive Process Measure..., 10/7/2003, 2 pages
	ADD	KATRONIC Non-invasive Ultrasonic Instrumentation for Flow, Level, Density and Conc..., 10/7/2003, 2 pages
	AEE	KATRONIC Measuring Principle Non-invasive Level Measurement & Control, 10/7/2003, 2 pages
	AFF	KATRONIC Non-invasive Continuous Level Measurement, 10/7/2003, 2 pages
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	AHH	MTS Liquid Level Sensors, http://www.technology.mtslevelsensors.com , 10/10/2003, 1 page
	AII	MTS Liquid Level Sensors, http://www.technology.mtslevelsensors.com , 10/10/2003, 2 pages
	AJJ	MTS Commercial Level Sensors, http://www.technology.mtslevelsensors.com , 10/10/2003, 2 pages
	AKK	MTS Liquid Level Sensors, http://www.technology.mtslevelsensors.com/namedPageViewer.php?keyword=sef , 10/10/2003, 2 pages
	ALL	Current directions of Ultrasonic Stress Measurement Techniques, Don E. Bray, Ph.D., http://www.ndt.net/article/wcndt00/papers/idn647/idn647.htm , 10/15/2003, 8 pages
	AMM	Ultrasonic Stress Measurement With the L _{CR} Technique, Don E. Bray, http://brayengr.com/lcrproc2.html , 10/15/2003, 14 pages
	ANN	Ultrasonic Measurements of Plastic Strain in Pipelines, Paul Panetta, et al., Pacific Northwest National Laboratory, 25 pages

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